Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/844,401	CHEN, ERNEST C.
Examiner	Art Unit
Emmanuel Bayard	2638

	SEAR	CHED	
Class	Subclass	Date	Examiner
375	262	8/1/05	xils
g	265	\ \ \	1
	279		
	281		
	282		
	298		
	308		
	311		
	316		
V	329		
375	295		
370	464		
	201	V	V
370	334	8/5/05	x's

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
375	295			
	324			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
XAST	8/5/05	ES		